

Data Sheet

FEATURES

Extreme high temperature operation -40°C to +210°C, 8-lead FLATPACK -40°C to +175°C, 8-lead SOIC Temperature coefficient 30 ppm/°C, 8-lead FLATPACK 10 ppm/°C, 8-lead SOIC High output current: 10 mA Low supply current: 50 µA maximum Initial accuracy: ±0.4% (±10 mV maximum), 8-lead SOIC Low dropout voltage Wide supply range: 3.3 V to 16 V

APPLICATIONS

Down-hole drilling and instrumentation Avionics Heavy industrial High temperature environments

GENERAL DESCRIPTION

The ADR225 is a precision 2.5 V band gap voltage reference specified for a high temperature operation of 175°C and 210°C. It uses a micropower core topology and laser trimming of highly stable, thin film resistors to achieve a temperature coefficient of 30 ppm/°C (maximum) up to 175°C and an initial accuracy of 0.4% (\pm 10 mV maximum). A maximum operating current of 50 μ A and a low dropout voltage allow the ADR225 to function very well in battery-powered equipment.

The ADR225 voltage reference is offered in an 8-lead SOIC package with an operating temperature range of -40° C to $+175^{\circ}$ C.

High Temperature, Low Drift, Micropower 2.5 V Reference

ADR225

PIN CONFIGURATION



It is also available in an 8-lead ceramic flat pack (FLATPACK) with an operating temperature range of -40° C to $+210^{\circ}$ C. Both devices are designed for robustness at extreme temperatures and are qualified for 1000 hours of operation at the maximum temperature rating.

The ADR225 is a member of a growing series of high temperature qualified products offered by Analog Devices, Inc. For a complete selection table of the available high temperature products, see the high temperature product list and qualification data available at www.analog.com/hightemp.

Rev. A

Document Feedback

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TABLE OF CONTENTS

Features	. 1
Applications	. 1
Pin Configuration	. 1
General Description	. 1
Revision History	. 2
Specifications	. 3
Electrical Characteristics	. 3
Absolute Maximum Ratings	.4

REVISION HISTORY

9/13-Rev. 0 to Rev. A

Changes to Data Sheet Title and Added Wide Supply Range: 3.3 V
to 16 V to Features Section
Changed Supply Voltage from -0.3 V to +15 V to -0.3 V to
+18 V; Table 2

7/13—Revision 0: Initial Version

Predicted Lifetime vs. Operating Temperature	4
Thermal Resistance	4
ESD Caution	4
Typical Performance Characteristics	5
Theory of Operation	8
Basic Voltage Reference Connections	8
Outline Dimensions	9
Ordering Guide	9

SPECIFICATIONS

ELECTRICAL CHARACTERISTICS

 V_{S} = 3.3 V, V_{OUT} = 2.5 V, T_{MIN} < T_{A} < T_{MAX} , unless otherwise noted.

Table 1.

			-	Lead S	DIC +175°C		ad FLAT $C \leq T_A \leq \frac{1}{2}$		
Parameter	Symbol	Test Conditions/Comments	Min	Тур	Max	Min	Тур	Max	Unit
SUPPLY CURRENT	I _{SY}	No load		30	50		35		μΑ
INITIAL ACCURACY ¹	Vo	Iout = 0 mA		±2	±10		±5		mV
TEMPERATURE COEFFICIENT ²	TCVout	Iout = 0 mA		10	30		30		ppm/°C
REGULATION									
Line Regulation	$\Delta V_{OUT}/\Delta V_{IN}$	$3.0 \text{ V} \le \text{V}_{\text{S}} \le 15 \text{ V}$, $I_{\text{OUT}} = 0 \text{ mA}$		5	40		5		ppm/V
Load Regulation ³	$\Delta V_{OUT}/\Delta V_{LOAD}$	$V_s = 5.0 \text{ V}, 0 \text{ mA} \le I_{OUT} \le 10 \text{ mA}$		10	40		10		ppm/mA
VOLTAGE									
Dropout Voltage	Vs — Vout	$I_{LOAD} = 10 \text{ mA}$			1.00		1.00		V
Noise Voltage	e _N	0.1 Hz to 10 Hz		25			25		μV p-р

 1 For proper operation, a 1 μF capacitor is required between the OUTPUT pin and the GND pin of the device.

² TCV_{out} is defined as the ratio of output change with temperature variation to the specified temperature range expressed in ppm/°C. $TCV_{out} = (V_{MAX} - V_{MIN})/V_{out}(T_{MAX} - T_{MIN})$

³ Load regulation specification includes the effect of self-heating.

ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating
Supply Voltage	–0.3 V to +18 V
OUTPUT to GND	-0.3 V to V _s + 0.3 V
Storage Temperature Range	–65°C to +150°C
Operating Temperature Range	
8-Lead SOIC	–40°C to +175°C
8-Lead FLATPACK	-40°C to +210°C
Junction Temperature Range	
8-Lead SOIC	-40°C to +200°C
8-Lead FLATPACK	–40°C to +245°C
Lead Temperature (Soldering 60 sec)	300°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

PREDICTED LIFETIME vs. OPERATING TEMPERATURE

Comprehensive reliability testing is performed on the ADR225. Product lifetimes at extended operating temperature are obtained using high temperature operating life (HTOL). Lifetimes are predicted from the Arrhenius equation, taking into account potential design and manufacturing failure mechanism assumptions. HTOL is performed to JEDEC JESD22-A108. A minimum of three wafer fab and assembly lots are processed through HTOL at the maximum operating temperature. Comprehensive reliability testing is performed on all Analog Devices, Inc., high temperature (HT) products.



THERMAL RESISTANCE

 θ_{JA} is specified for worst-case conditions; that is, θ_{JA} is specified for the device soldered in the circuit board.

Table 3.

Package Type	θ」Α	οισ	Unit
8-Lead SOIC	121	43	°C/W
8-Lead FLATPACK	100	15	°C/W

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

TYPICAL PERFORMANCE CHARACTERISTICS

 V_{S} = 3.3 V, V_{OUT} = 2.5 V, T_{MIN} \leq T_{A} \leq T_{MAX} for 8-lead SOIC package, unless otherwise noted.



Figure 5. Output Voltage Accuracy at 175°C







Figure 14. Power Supply Rejection Ratio (PSRR) vs. Frequency, $C_{LOAD} = 1 \, \mu F$

Data Sheet



Figure 15. Output Impedance (Z_{OUT}) vs. Frequency, $C_{IN} = C_{OUT} = 1 \, \mu F$

THEORY OF OPERATION BASIC VOLTAGE REFERENCE CONNECTIONS

The circuit shown in Figure 16 is the basic configuration for the ADR225. Note that a 10 μ F and 0.1 μ F bypass network on the input and at least a 1 μ F bypass capacitor on the output are required for proper device operation. It is recommended that no connections be made to Pin 1, Pin 3, Pin 5, Pin 7, and Pin 8.



Figure 16. Basic Voltage Reference Connections



Figure 17. Typical High Temperature Resistance Temperature Detector (RTD) Signal Conditioning Circuit

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OUTLINE DIMENSIONS



(F-8-2) Dimensions shown in inches

ORDERING GUIDE

Model ¹ Temperature Range		Package Description	Package Option
ADR225HRZN	–40°C to +175°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8
ADR225HFZ	-40°C to +210°C	8-Lead Ceramic Flat Package [FLATPACK]	F-8-2

¹ Z = RoHS Compliant Part.

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